MOSFET – Power

60 V, 37 A, 11.5 mΩ

Features

- Low R_{DS(on)}
- Low Capacitance
- Optimized Gate Charge
- These Devices are Pb-Free and are RoHS Compliant

MAXIMUM RATINGS (T_J = 25° C unless otherwise stated)

Param	Symbol	Value	Unit			
Drain-to-Source Voltage	V _{DSS}	60	V			
Gate-to-Source Voltage			V _{GS}	±20	V	
Continuous Drain		$T_A = 25^{\circ}C$	Ι _D	11	А	
Current $R_{\theta JA}$ (Note 1)		$T_A = 100^{\circ}C$		7		
Power Dissipation $R_{\theta JA}$		$T_A = 25^{\circ}C$	PD	2.7	W	
(Note 1)	Steady	$T_A = 100^{\circ}C$		1.1		
Continuous Drain	State	$T_{C} = 25^{\circ}C$	Ι _D	37	А	
Current $R_{\theta JC}$ (Note 1)		$T_{C} = 100^{\circ}C$		24		
Power Dissipation		T _C = 25°C	PD	33	W	
R _{θJC} (Note 1)		$T_{C} = 100^{\circ}C$		13		
Pulsed Drain Current	t _p =	10 μs	I _{DM}	149	А	
Operating Junction and S	T _J , T _{stg}	–55 to +150	°C			
Source Current (Body Die	۱ _S	37	А			
Single Pulse Drain-to-Source Ava- L = 0.1 mH			E _{AS}	48	mJ	
lanche Energy		I _{AS}	31	А		
Lead Temperature for Soldering Purposes (1/8" from case for 10 s)			ΤL	260	°C	

Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit	
Junction-to-Case - Steady State (Note 1)	$R_{ heta JC}$	3.8	°C/W	
Junction-to-Ambient - Steady State (Note 1)	$R_{ hetaJA}$	46.7		

 Surface-mounted on FR4 board using 1 in sq pad size (Cu area = 1.127 in sq [2 oz] including traces.

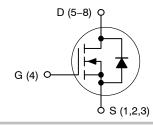


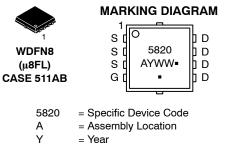
ON Semiconductor®

http://onsemi.com

V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX	
60 V	11.5 mΩ @ 10 V	37 A	
	15 mΩ @ 4.5 V	57 A	







WW = Work Week = Pb-Free Package

(Note: Microdot may be in either location)

ORDERING INFORMATION

Device	Package	Shipping [†]
NTTFS5820NLTAG	WDFN8 (Pb-Free)	1500 / Tape & Reel
NTTFS5820NLTWG	WDFN8 (Pb-Free)	5000 / Tape & Reel

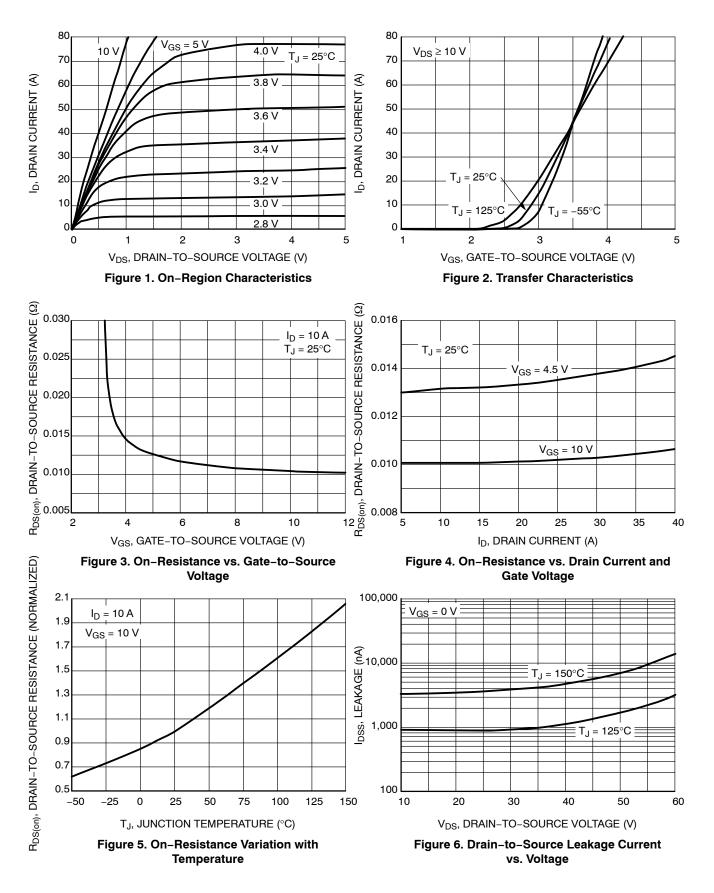
+For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

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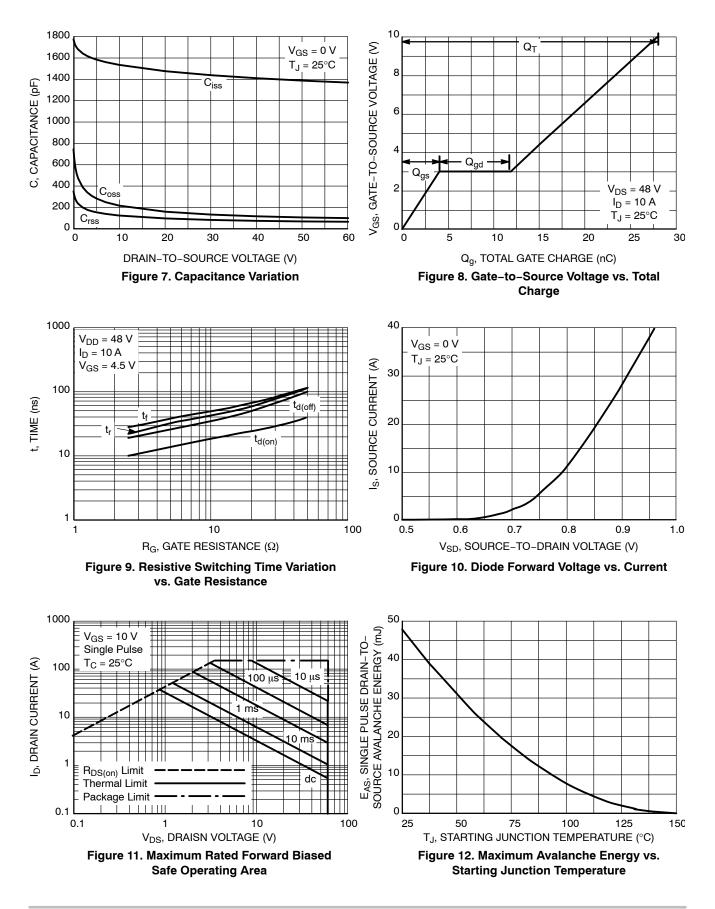
ELECTRICAL CHARACTERISTICS (T_J = 25° C unless otherwise specified)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
OFF CHARACTERISTICS	•					•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	V _{GS} = 0 V, I _D = 250 μA		60			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				57		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$			1.0	μΑ
		$V_{DS} = 60 V$	$T_J = 125^{\circ}C$			10	
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V _{GS}	= ±20 V			±100	nA
ON CHARACTERISTICS (Note 2)							
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}, I_D =$	= 250 μA	1.5		2.3	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				6.2		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 8.7 A		10.1	11.5	mΩ
		V _{GS} = 4.5 V	l _D = 7.3 A		13.0	15	1
Forward Transconductance	9 FS	$V_{DS} = 5 \text{ V}, \text{ I}_D$	= 10 A		24.6		S
CHARGES, CAPACITANCES AND GA	ATE RESISTAN	ICE					-
Input Capacitance	C _{iss}				1462		pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, f = 1.0 MH	lz, V _{DS} = 25 V		150		1
Reverse Transfer Capacitance	C _{rss}				96		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 10 V, V _{DS} = 4	8 V, I _D = 10 A		28		nC
		V _{GS} = 4.5 V, V _{DS} = 4	8 V, I _D = 10 A		15		
Threshold Gate Charge	Q _{G(TH)}				1		nC
Gate-to-Source Charge	Q _{GS}				4		
Gate-to-Drain Charge	Q _{GD}	V _{GS} = 4.5 V, V _{DS} = 4	18 V, I _D = 10 A		8		
Plateau Voltage	V _{GP}				3		V
Gate Resistance	R _G				0.62		Ω
SWITCHING CHARACTERISTICS (No	ote 3)						
Turn-On Delay Time	t _{d(on)}				10		ns
Rise Time	t _r	V _{GS} = 4.5 V, V _D	_S = 48 V,		28		1
Turn-Off Delay Time	t _{d(off)}	$I_{\rm D} = 10 \rm A, R_{\rm G}$	= 2.5 Ω		19		
Fall Time	t _f	1			22		
DRAIN-SOURCE DIODE CHARACTE	RISTICS						-
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	$T_J = 25^{\circ}C$		0.79	1.2	V
		$I_{\rm S} = 10 \rm A$	$T_J = 125^{\circ}C$		0.65	1	1
Reverse Recovery Time	t _{RR}	V_{GS} = 0 V, d _{IS} /d _t = 100 A/µs, I _S = 10 A			19	1	ns
Charge Time	t _a				13	1	1
Discharge Time	t _b				6		1
Reverse Recovery Charge	Q _{RR}				15		nC

TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS



TYPICAL CHARACTERISTICS

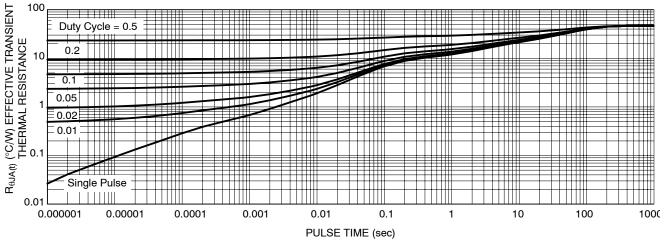
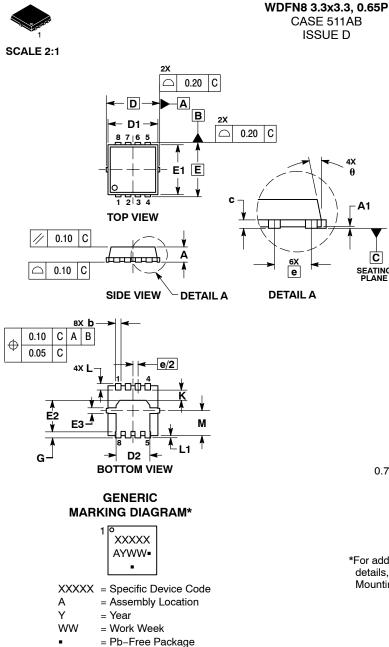


Figure 13. Thermal Response

DURSEM

DATE 23 APR 2012



*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

NOTES:

A1

C

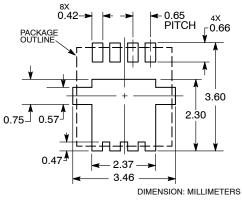
SEATING PLANE

LES: DIMENSIONING AND TOLERANCING PER ASME Y14.5M, 1994. CONTROLLING DIMENSION: MILLIMETERS. DIMENSION D1 AND E1 DO NOT INCLUDE MOLD FLASH PROTRUSIONS OR GATE BURRS. 1. 2.

- 3.

	MILLIMETERS			INCHES			
DIM	MIN	NOM	MAX	MIN	NOM	MAX	
Α	0.70	0.75	0.80	0.028	0.030	0.031	
A1	0.00		0.05	0.000		0.002	
b	0.23	0.30	0.40	0.009	0.012	0.016	
с	0.15	0.20	0.25	0.006	0.008	0.010	
D	3.30 BSC			0.130 BSC			
D1	2.95	3.05	3.15	0.116	0.120	0.124	
D2	1.98	2.11	2.24	0.078	0.083	0.088	
E	3.30 BSC			0.130 BSC			
E1	2.95	3.05	3.15	0.116	0.120	0.124	
E2	1.47	1.60	1.73	0.058	0.063	0.068	
E3	0.23	0.30	0.40	0.009	0.012	0.016	
е	0.65 BSC			0.026 BSC			
G	0.30	0.41	0.51	0.012	0.016	0.020	
к	0.65	0.80	0.95	0.026	0.032	0.037	
L	0.30	0.43	0.56	0.012	0.017	0.022	
L1	0.06	0.13	0.20	0.002	0.005	0.008	
М	1.40	1.50	1.60	0.055	0.059	0.063	
θ	0 °		12 °	0 °		12 °	

SOLDERING FOOTPRINT*



*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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